

_	Application No.	Applicant(s)
	10/021,531	PHAN ET AL.
	Examiner	Art Unit
	Binh X Tran	1765

	SEARCHED				
Class	Subclass	Date	Examiner		
156	345.24	7/1/2004	Bt		
156	345.25	7/1/2004	3		
156	345.26	7/1/2004	BT		
156	345.33	7/1/2004	町		
156	345.51	7/1/2004	BT		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
156	345.24	7/1/2004	bi	
156	345.25	7/1/2004	助	
156	345.26	7/1/2004	MT	
156/345.33 156/345.51		7/1/2004	15+	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Update keywords and inventors' name search using EAST	7/1/2004	り り か		
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